

MOSFET - N-Channel, QFET

250 V, 16 A, 270 mΩ

FQD16N25C

Description

This N-Channel Enhancement Mode Power MOSFET is produced using **onsemi**'s proprietary planar stripe and DMOS technology. This advanced MOSFET technology has been especially tailored to reduce on-state resistance, and to provide superior switching performance and high avalanche energy strength. These devices are suitable for switched mode power supplies, active power factor correction (PFC), and electronic lamp ballasts.

Features

- 16 A, 250 V $R_{DS(on)} = 270 \text{ m}\Omega \text{ (Max.)} @ V_{GS} = 10 \text{ V}, I_D = 8 \text{ A}$
- Low Gate Charge (Typ. 41 nC)
- Low C_{rss} (Typ. 68 pF)
- 100% Avalanche Tested
- This Device is Pb-Free.

ABSOLUTE MAXIMUM RATINGS

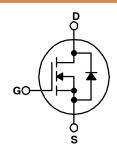
 $(T_C = 25^{\circ}C \text{ unless otherwise noted.})$

Symbol	Parameter	Value	Unit
V_{DSS}	Drain-Source Voltage	250	V
I _D	Drain Current - Continuous (T _C = 25°C) - Continuous (T _C = 100°C)	16 10.1	Α
I _{DM}	Drain Current - Pulsed (Note 1)	64	Α
V_{GSS}	Gate-Source Voltage ±30		V
E _{AS}	Single Pulsed Avalanche Energy (Note 2)	432	mJ
I _{AR}	Avalanche Current (Note 1)	16	Α
E _{AR}	Repetitive Avalanche Energy (Note 1)	160	mJ
dv/dt	Peak Diode Recovery dv/dt (Note 3)	5.5	V/ns
P _D	Power Dissipation - (T _C = 25°C) - Derate Above 25°C	160 1.28	W W/°C
T _J ,T _{STG}	Operating and Storage Temperature Range	-55 to +150	°C
TL	Maximum Lead Temperature for Soldering Purpose, 1/8" from Case for 5 Seconds	300	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.



DPAK3 CASE 369AS



MARKING DIAGRAM

&Z&3&K FQD 16N25C

&Z = Assembly Plant Code &3 = Date Code (Year & week) &K = 2-Digit Lot Code FQD16N25C = Specific Device Code

ORDERING INFORMATION

Device	Package	Shipping [†]	
FQD16N25CTM	DPAK3	2500 /	
	(Pb-Free)	Tape & Reel	

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

THERMAL CHARACTERISTICS

Symbol	Parameter	Value	Unit
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case, Max	0.78	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient, Max.	110	

ELECTRICAL CHARACTERISTICS (T_C = 25°C unless otherwise noted)

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
Off Charac	cteristics		-	-	-	
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} = 0 V, I _D = 250 μA	250	_	_	V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I_D = 250 μ A, Referenced to 25°C	-	0.31	-	V/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 250 V, V _{GS} = 0 V	-	_	10	μΑ
		V _{DS} = 200 V, T _C = 125°C	-	-	100	μΑ
I _{GSSF}	Gate-Body Leakage Current, Forward	V _{GS} = 30 V, V _{DS} = 0 V	_	_	100	nA
I _{GSSR}	Gate-Body Leakage Current, Reverse	$V_{GS} = -30 \text{ V}, V_{DS} = 0 \text{ V}$	-	_	-100	nA
On Charac	cteristics				•	
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250 \mu A$	2.0	_	4.0	V
R _{DS(on)}	Static Drain-Source On-Resistance	V _{GS} = 10 V, I _D = 8 A	-	0.22	0.27	Ω
9FS	Forward Transconductance	V _{DS} = 40 V, I _D = 8 A	-	10.5	_	S
Dynamic 0	Characteristics					
C _{iss}	Input Capacitance	$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V}, f = 1.0 \text{ MHz}$	_	830	1080	pF
C _{oss}	Output Capacitance		_	170	220	pF
C_{rss}	Reverse Transfer Capacitance		_	68	89	pF
Switching	Characteristics					
t _{d(on)}	Turn-On Delay Time	$V_{DD} = 125 \text{ V}, I_{D} = 16 \text{ A},$ $R_{G} = 25 \Omega \text{ (Note 4)}$	_	15	40	ns
t _r	Turn-On Rise Time		_	130	270	ns
t _{d(off)}	Turn-Off Delay Time		_	135	280	ns
t _f	Turn-Off Fall Time		-	105	220	ns
Q_g	Total Gate Charge	$V_{DS} = 200 \text{ V}, I_D = 16 \text{ A},$	_	41	53.5	nC
Q_{gs}	Gate-Source Charge	V _{GS} = 10 V (Note 4)	_	5.6	_	nC
Q_{gd}	Gate-Drain Charge		-	22.7	_	nC
Drain-Soเ	rce Diode Characteristics and Maximum I	Ratings				
I _S	Maximum Continuous Drain-Source Diode Forward Current		_	_	16	Α
I _{SM}	Maximum Pulsed Drain-Source Diode For	ward Current	_	_	64	Α
V_{SD}	Drain-Source Diode Forward Voltage	V _{GS} = 0 V, I _S = 16 A	_	-	1.5	V
t _{rr}	Reverse Recovery Time	V _{GS} = 0 V, I _S = 16 A, dI _F /dt = 100 A/μs	-	260	_	ns
Q _{rr}	Reverse Recovery Charge		-	2.47	-	μС

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

NOTES:

- 1. Repetitive Rating: Pulse width limited by maximum junction temperature.
 2. L = 2.7 mH, I_{AS} = 16 A, V_{DD} = 50 V, R_{G} = 25, Ω starting T_{J} = 25°C.
 3. $I_{SD} \le$ 16 A, di/dt \le 300 A/ μ s, $V_{DD} \le$ BV $_{DSS}$, starting T_{J} = 25°C.
 4. Essentially independent of operating temperature.

TYPICAL CHARACTERISTICS

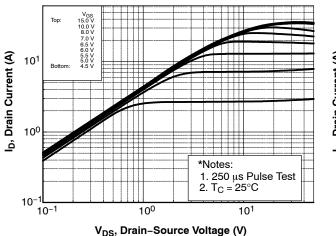


Figure 1. On-Region Characteristics

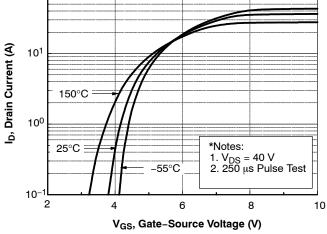


Figure 2. Transfer Characteristics

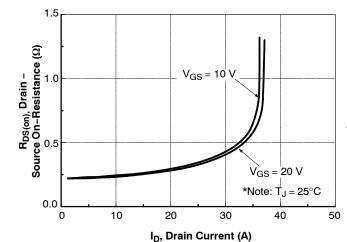


Figure 3. On–Resistance Variation vs
Drain Current and Gate Voltage

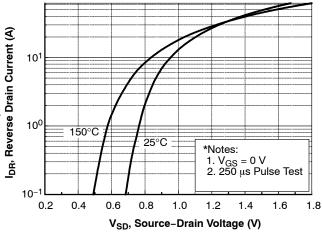


Figure 4. Body Diode Forward Voltage Variation vs Source Current and Temperature

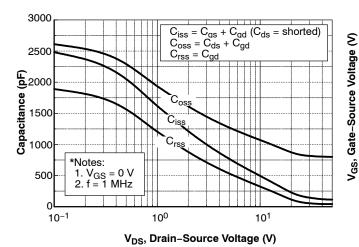


Figure 5. Capacitance Characteristics

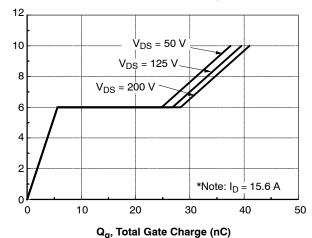


Figure 6. Gate Charge Characteristics

TYPICAL CHARACTERISTICS (CONTINUED)

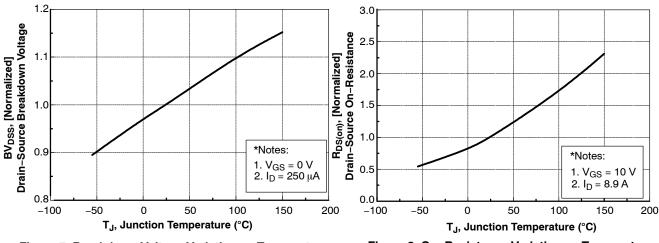


Figure 7. Breakdown Voltage Variation vs Temperature

Figure 8. On-Resistance Variation vs Temperature

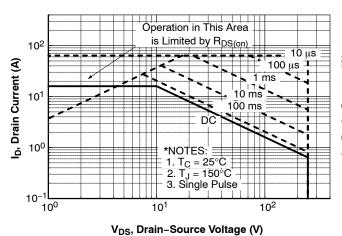


Figure 9. Maximum Safe Operating Area

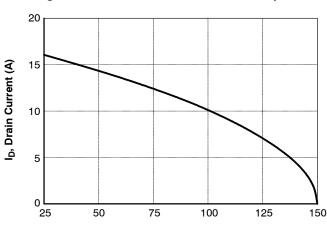
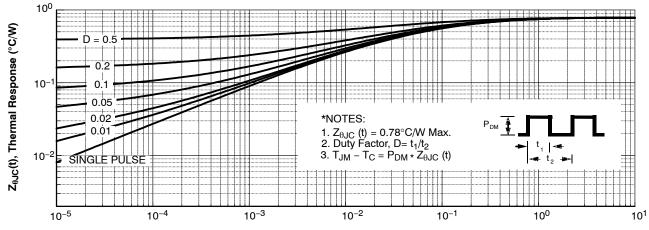


Figure 10. Maximum Drain Current

T_C, Case Temperature (°C)





t₁, Rectangular Pulse Duration (s)

Figure 11. Transient Thermal Response Curve

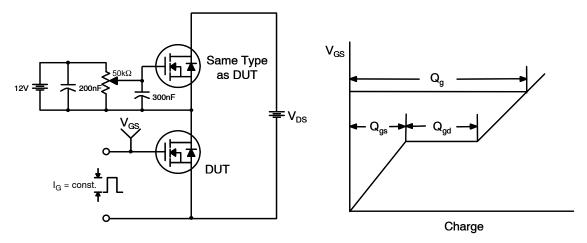


Figure 12. Gate Charge Test Circuit & Waveform

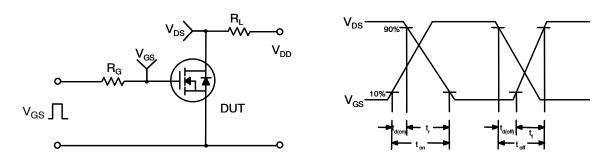


Figure 13. Resistive Switching Test Circuit & Waveforms

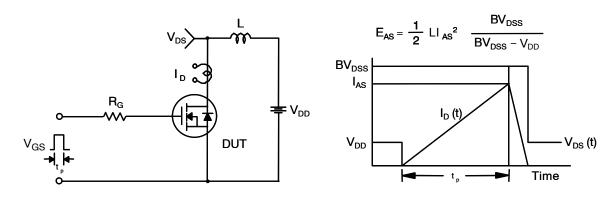
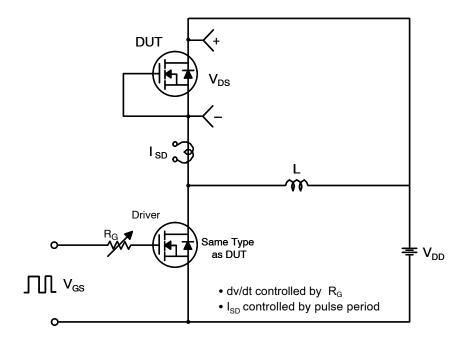


Figure 14. Unclamped Inductive Switching Test Circuit & Waveforms



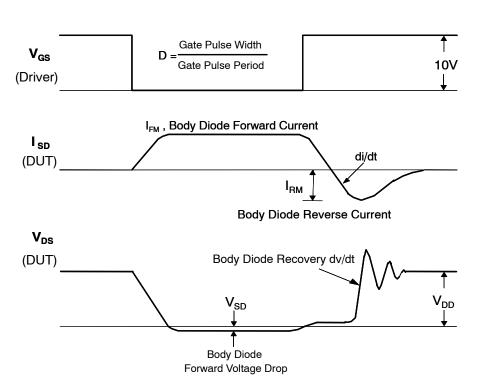


Figure 15. Peak Diode Recovery dv/dt Test Circuit & Waveforms





DPAK3 6.10x6.54x2.29, 4.57P CASE 369AS **ISSUE B**

DATE 20 DEC 2023

- NOTES: UNLESS OTHERWISE SPECIFIED

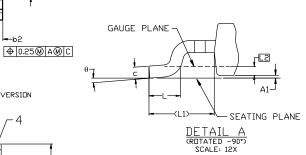
 A) THIS PACKAGE CONFORMS TO JEDEC, TO-252, ISSUE F, VARIATION AA.

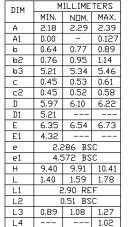
 B) ALL DIMENSIONS ARE IN MILLIMETERS.

 C) DIMENSIONING AND TOLERANCING PER

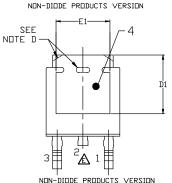
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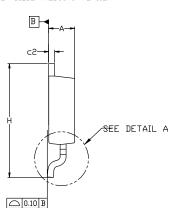
- A
- F)
- DIMENSIONING AND TOLERANCING PER
 ASME Y14.5M-2018.
 SUPPLIER DEPENDENT MOLD LOCKING HOLES OR CHAMFERED
 CORNERS OR EDGE PROTRUSION.
 FOR DIGDE PRODUCTS, L4 IS 0.25 MM MAX PLASTIC BODY
 STUB WITHOUT CENTER LEAD.
 DIMENSIONS ARE EXCLUSIVE OF BURRS,
 MOLD FLASH AND TIE BAR EXTRUSIONS.
 LAND PATTERN RECOMMENDATION IS BASED ON IPC7351A STD
 T0228P991X239-3N.





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A

-5.55	MIN-
	6.50 MIN
6.40 LXXX	
1	2.85 MIN
	1.25 MIN
4.5	2.286

LAND PATTERN RECOMMENDATION

*FOR ADDITIONAL INFORMATION ON OUR PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ON SEMICONDUCTOR SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.

GENERIC MARKING DIAGRAM*

10°

XXXXXX XXXXXX **AYWWZZ**

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "■", may or may not be present. Some products may not follow the Generic Marking.

XXXX = Specific Device Code

= Assembly Location Α

Υ = Year

WW = Work Week

77 = Assembly Lot Code

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